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2-(2,2-Dibromoethenyl)thiophene

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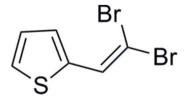
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Key indicators: single-crystal X-ray study; T = 173 K; mean σ (C–C) = 0.007 Å; R factor = 0.058; wR factor = 0.139; data-to-parameter ratio = 20.3.

The title compound, $C_6H_4Br_2S$, represents a versatile building block for the preparation of π -conjugated redox-active thienyl oligomers and metal-mediated cross-coupling reactions. This is due to the presence of an electrochemically active thienyl heterocycle and a reactive dibromovinyl substituent, which easily undergoes dehydrobromination in the presence of nbutyllithium to afford 2-ethynylthiophene. In the molecule, the alkenyl unit and the thiophene ring are almost coplanar with an angle of $3.5(2)^{\circ}$ between the normals of the best planes of the thiophene ring and the vinyl moiety.

Related literature

The title compound was first prepared in 1980, see: Bestmann et al. (1980). For an alternative synthesis using a Corey-Fuchs reaction, see: Beny et al. (1982). For a structural comparison with 2,2-dibromovinyl[2,2]paracyclophane [PCP-C(H)= CBr_2], (2,2-dibromovinyl)ferrocene [Fc-C(H)=CBr_2], and 2-thienylmethylenemalononitrile $[C_4H_3S-C(H)=C(CN)_2]$, see: Clément et al. (2007a,b) and Mukherjee et al. (1984), respectively. For recent applications, see: Herz et al. (1999); Rao et al. (2010); Zhang et al. (2010).



Experimental

Crystal data

$C_6H_4Br_2S$	V = 760.4 (3) Å ³
$M_r = 267.97$	Z = 4
Monoclinic, $P2_1/c$	Mo $K\alpha$ radiation
a = 9.6843 (19) Å	$\mu = 10.84 \text{ mm}^{-1}$
b = 7.2379 (14) Å	T = 173 K
c = 11.484 (2) Å	$0.4 \times 0.4 \times 0.2 \text{ mm}$
$\beta = 109.16 \ (3)^{\circ}$	
Data collection	

D

Stoe IPDS diffractometer Absorption correction: numerical (FACEIT in IPDS; Stoe & Cie, 1999) $T_{\min} = 0.188, T_{\max} = 0.658$

Refinement

$R[F^2 > 2\sigma(F^2)] = 0.058$	82 pa
$wR(F^2) = 0.139$	H-ato
S = 1.04	$\Delta ho_{\rm ma}$
1667 reflections	$\Delta ho_{ m min}$

6492 measured reflections 1667 independent reflections 1444 reflections with $I > 2\sigma(I)$ $R_{\rm int} = 0.064$

arameters om parameters not refined $_{ax} = 1.36 \text{ e} \text{ Å}^{-3}$ $_{\rm in} = -1.73 \ {\rm e} \ {\rm \AA}^{-3}$

Data collection: EXPOSE in IPDS (Stoe & Cie, 1999); cell refinement: CELL in IPDS; data reduction: INTEGRATE in IPDS; program(s) used to solve structure: SHELXS97 (Sheldrick, 2008); program(s) used to refine structure: SHELXL97 (Sheldrick, 2008); molecular graphics: ORTEP-3 (Farrugia, 1997); software used to prepare material for publication: WinGX (Farrugia, 1999).

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Supplementary data and figures for this paper are available from the IUCr electronic archives (Reference: IM2256).

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2-(2,2-Dibromoethenyl)thiophene

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S1. Comment

The title compound (Scheme 1, Fig. 1), which is easily accessible from thiophene-2-carbaldehyde *via* the Corey-Fuchs reaction, has over the last 30 years become a versatile starting material for a variety of organic transformations and a precursor in material science. This interest is due to the conjugation between the electrochemically active thienyl heterocycle with the reactive halogenated olefin moiety. Originally it was used for the preparation of terthiophenes (Beny *et al.*, 1982). Recent applications include Pd-catalyzed cross-coupling reactions (Herz *et al.*, 1999; Rao *et al.*, 2010) as well as the synthesis of imidazo[1,5- α]pyridines (Zhang *et al.*, 2010).

In the course of our interest in developing new π -conjugated dihalovinyl compounds R—C(H)=CX₂ with functional groups (*R* = imine, ferrocenyl, [2,2]paracyclophane) as substrates for oxidative addition reactions across low-valent noble metals, we have recently reported the synthesis and crystal structures of 4-2',2'-dibromovinyl[2,2]paracyclophane (Clément *et al.* 2007*a*) and (2,2-dibromovinyl)ferrocene (Clément *et al.* 2007*b*). With this aim in mind, we also prepared the title compound 2-(2,2-dibromoethenyl)thiophene. A survey of the CSD data base revealed that neither 2-vinylthiophene nor a halogenated derivative of the types [C₄H₃S—C(H)=C(H)X] or [C₄H₃S—C(H)=CX₂] (*X* = halogen) had been structurally characterized yet. The most related molecule found is 2-thienylmethylenemalononitrile [C₄H₃S—C(H)=C(CN)₂] (Mukherjee *et al.*, 1984). In the latter compound, the angle between the normals of the two planar parts of the molecule, the thiophene cycle and the dicyanovinyl moiety, amounts to 3.6 (5)°. In the title compound, the corresponding angle lies in the same range [3.5 (2)°]. A somewhat larger angle of 10.4° has been determined for (2,2-dibromovinyl)ferrocene [Fc—C(H)=CBr₂] (Clément *et al.*, 2007*b*), whereas in 4-(2',2'-dibromovinyl)[2,2]paracyclophane [PCP—C(H)=CBr₂] an angle of 51.1° has been observed significantly deviating from coplanarity (Clément *et al.*, 2007*a*). The length of the vinylic C1—C2 double bond [1.335 (7) Å] matches well with those of [PCP—C(H)=CBr₂] [1.320 (3)°] and [Fc—C(H)=CBr₂] [1.318 (4) Å] (Clément *et al.*, 2007*a*; Clément *et al.*, 2007*b*). A similar bond length of 1.353 (5) Å has also been reported for [C₄H₃S—C(H)=C(CN)₂] (Mukherjee *et al.*, 1984).

Bond lenths and angles of the thienyl moiety may be considered as normal and deserve no further comment. The unit cell consists of 4 molecules which are held together by weak interactions only (Fig. 2). These consist of the short Br1—Br2 distance [3.6501 (9) Å, Br1_5-Br2_2] as well as the short distances between Br2 and the carbon atoms of the thiophene ring [3.604 (5) Å, Br2_2-C4; 3.479 (6) Å, Br2_2-C5; 3.624 (5) Å, Br2_2-C6].

S2. Experimental

Triphenylphosphine (4.20 g, 16.0 mmol), CBr₄ (5.31 g, 16.0 mmol) and zinc dust (1.05 g, 16.0 mmol) were placed in a Schlenk tube and 40 ml of CH_2Cl_2 were slowly added. The mixture was stirred at room temperature for 28 h. Then, 2-thiophenecarboxaldehyde (0.89 g, 8.00 mmol) in CH_2Cl_2 (10 ml) was added and stirring was continued for further 2 h. The reaction mixture was extracted with three 50 ml portions of pentane. CH_2Cl_2 was added when the reaction mixture became too viscous for further extractions. The extracts were filtered and evaporated under reduced pressure. The crude

product was purified by column chromatography on silica gel with CH_2Cl_2 /petroleum ether (1:4). Slow evaporation afforded white crystals of 2-(2,2-dibromoethenyl)thiophene (yield: 90%). Characterization data have been previously described in the literature. (Beny *et al.*, 1982)

S3. Refinement

H atoms were refined using a riding model in their ideal geometric positions using the riding model approximation with $U_{iso}(H) = 1.2U_{eq}(C)$ for all H atoms.

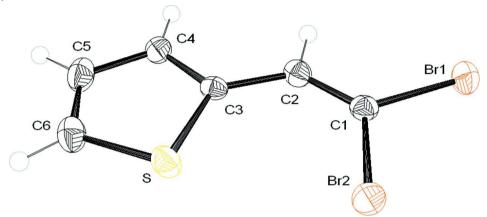


Figure 1

Molecular structure of the title compound with thermal ellipsoids drawn at the 50% probability level.

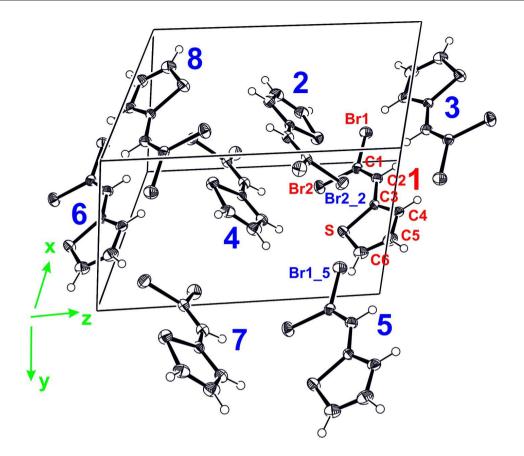


Figure 2

Crystal packing of 2-(2,2-dibromoethenyl)thiophene. Symmetry operations: (1) x, y, z; (2) -x, y - 1/2, -z - 1/2; (3) -x, -y - 1, -z; (4) x, -y + 1/2, z - 1/2; (5) x - 1, y, z; (6) x, y - 1, z; (7) x - 1, -y + 1/2, z - 1/2; (8) -x, -y - 1, -z - 1.

2-(2,2-Dibromoethenyl)thiophene

Crystal data	
$C_{6}H_{4}Br_{2}S$ $M_{r} = 267.97$ Monoclinic, $P2_{1}/c$ Hall symbol: -P 2ybc a = 9.6843 (19) Å b = 7.2379 (14) Å c = 11.484 (2) Å $\beta = 109.16 (3)^{\circ}$ $V = 760.4 (3) Å^{3}$ Z = 4	F(000) = 504 $D_x = 2.341 \text{ Mg m}^{-3}$ Mo Ka radiation, $\lambda = 0.71073 \text{ Å}$ Cell parameters from 980 reflections $\theta = 2.2-27.0^{\circ}$ $\mu = 10.84 \text{ mm}^{-1}$ T = 173 K Plates, colourless $0.4 \times 0.4 \times 0.2 \text{ mm}$
Data collection	
Stoe IPDS diffractometer Graphite monochromator φ scans Absorption correction: numerical (FACEIT in <i>IPDS</i> ; Stoe & Cie, 1999) $T_{\min} = 0.188, T_{\max} = 0.658$ 6492 measured reflections	1667 independent reflections 1444 reflections with $I > 2\sigma(I)$ $R_{int} = 0.064$ $\theta_{max} = 27.0^\circ, \theta_{min} = 2.2^\circ$ $h = -11 \rightarrow 12$ $k = -9 \rightarrow 9$ $l = -14 \rightarrow 14$

Refinement

5	
Refinement on F^2	Secondary atom site location: difference Fourier
Least-squares matrix: full	map
$R[F^2 > 2\sigma(F^2)] = 0.058$	Hydrogen site location: inferred from
$wR(F^2) = 0.139$	neighbouring sites
S = 1.04	H-atom parameters not refined
1667 reflections	$w = 1/[\sigma^2(F_o^2) + (0.1099P)^2]$
82 parameters	where $P = (F_o^2 + 2F_c^2)/3$
0 restraints	$(\Delta/\sigma)_{\rm max} < 0.001$
Primary atom site location: structure-invariant	$\Delta \rho_{\rm max} = 1.36 \text{ e} \text{ Å}^{-3}$
direct methods	$\Delta \rho_{\rm min} = -1.73 \ {\rm e} \ {\rm \AA}^{-3}$
	-

Special details

Geometry. All e.s.d.'s (except the e.s.d. in the dihedral angle between two l.s. planes) are estimated using the full covariance matrix. The cell e.s.d.'s are taken into account individually in the estimation of e.s.d.'s in distances, angles and torsion angles; correlations between e.s.d.'s in cell parameters are only used when they are defined by crystal symmetry. An approximate (isotropic) treatment of cell e.s.d.'s is used for estimating e.s.d.'s involving l.s. planes.

Refinement. Refinement of F^2 against ALL reflections. The weighted *R*-factor *wR* and goodness of fit *S* are based on F^2 , conventional *R*-factors *R* are based on *F*, with *F* set to zero for negative F^2 . The threshold expression of $F^2 > \sigma(F^2)$ is used only for calculating *R*-factors(gt) *etc.* and is not relevant to the choice of reflections for refinement. *R*-factors based on F^2 are statistically about twice as large as those based on *F*, and *R*- factors based on ALL data will be even larger.

Fractional atomic coordinates and isotropic or equivalent isotropic displacement parameters (\mathring{A}^2)

	x	У	Ζ	$U_{ m iso}$ */ $U_{ m eq}$	
Br1	0.90429 (5)	0.69525 (7)	0.15399 (5)	0.0306 (2)	
Br2	0.75506 (5)	0.94572 (7)	0.30330 (4)	0.0290 (2)	
C1	0.7287 (5)	0.7946 (6)	0.1647 (4)	0.0214 (9)	
C2	0.5999 (5)	0.7559 (7)	0.0803 (4)	0.0225 (9)	
H2	0.6061	0.6818	0.0139	0.027*	
C3	0.4530 (5)	0.8068 (6)	0.0720 (4)	0.0188 (8)	
C4	0.3277 (5)	0.7471 (7)	-0.0213 (4)	0.0225 (9)	
H4	0.3305	0.6695	-0.0873	0.027*	
C5	0.1970 (6)	0.8134 (7)	-0.0080(5)	0.0307 (11)	
Н5	0.1026	0.7857	-0.0637	0.037*	
C6	0.2213 (5)	0.9216 (7)	0.0939 (5)	0.0289 (10)	
H6	0.1455	0.9771	0.1174	0.035*	
S	0.40366 (13)	0.94655 (17)	0.17497 (12)	0.0265 (3)	

Atomic displacement parameters $(Å^2)$

	U^{11}	U^{22}	U^{33}	U^{12}	U^{13}	U^{23}
Br1	0.0220 (3)	0.0379 (4)	0.0324 (3)	0.00528 (18)	0.0097 (2)	-0.0004 (2)
Br2	0.0268 (3)	0.0342 (3)	0.0250 (3)	-0.00466 (18)	0.0072 (2)	-0.00800 (17)
C1	0.024 (2)	0.021 (2)	0.0202 (19)	0.0009 (16)	0.0089 (17)	0.0037 (16)
C2	0.024 (2)	0.020 (2)	0.024 (2)	0.0027 (18)	0.0104 (18)	0.0016 (17)
C3	0.024 (2)	0.0157 (19)	0.0183 (19)	0.0008 (15)	0.0095 (17)	0.0015 (15)
C4	0.024 (2)	0.020 (2)	0.024 (2)	0.0029 (17)	0.0083 (18)	0.0041 (17)
C5	0.020 (2)	0.034 (3)	0.036 (3)	-0.0005 (18)	0.005 (2)	0.006 (2)
C6	0.022 (2)	0.028 (2)	0.037 (3)	-0.0003 (18)	0.011 (2)	0.003 (2)

5	0.0256 (6)	0.0287 (6)	0.0277 (6)	0.0006 (4)	0.0121 (5)	-0.0054 (4)
		(3 0)				
теот	etric parameters ((A, ⁻)				
Br1—	C1	1.88	7 (5)	C4—C5	1.408 (7)	
Br2—	C1	1.87	8 (5)	C4—H4		0.95
C1—C	22	1.33	5 (7)	C5—C6		1.362 (8)
C2—C	23	1.44	2 (6)	С5—Н5		0.95
С2—н	H2	0.95		C6—S		1.714 (5)
С3—С	C4	1.39	7 (7)	С6—Н6	0.95	
C3—S	5	1.73	8 (4)			
22—0	C1—Br2	124.	9 (4)	C3—C4—H4		123.3
C2—C			С5—С4—Н4		123.3	
Br2—	C1—Br1	113.	7 (3)	C6—C5—C4		112.4 (5)
C1—0	С2—С3	131.	4 (4)	С6—С5—Н5		123.8
C1—0	—С2—Н2		3	C4—C5—H5		123.8
С3—С	—С2—Н2		3	C5—C6—S		112.6 (4)
C4—C	С3—С2	124.	1 (4)	С5—С6—Н6		123.7
C4—C	C3—S	109.	8 (3)	S-C6-H6		123.7
C2—0	C3—S	126.	1 (3)	C6—S—C3		91.9 (2)
C3—(C4—C5	113.	3 (4)			

supporting information